

#### **Automotive MOSFET**

#### **OptiMOS™ 5 Power-Transistor**







#### **Features**

- OptiMOS<sup>™</sup> power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL3 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested



General automotive applications.

#### **Product validation**

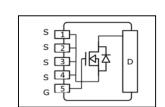
Qualified for automotive applications. Product validation according to AEC-Q101.

## **Product Summary**

$V_{ m DS}$	40	V
R <sub>DS(on),max</sub>	0.94	mΩ
I <sub>D</sub> (chip limited)	200	Α

Туре	Package	Marking
IAUA200N04S5N010	PG-HSOF-5-1	5N04N010





IAUA200N04S5N010



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IAUA200N04S5N010



# **Maximum ratings**

at Tj=25 °C, unless otherwise specified

Parameter	Symbol	l Conditions Value		Unit
Continuous dusis suurent	I <sub>D</sub>	$T_{\rm C} = 25 {\rm ^{\circ}C}, V_{\rm GS} = 10 {\rm V}^{1)}$	200	А
Continuous drain current		$T_{\rm C} = 100 {\rm ^{\circ}C},  V_{\rm GS} = 10 {\rm V}^{2)}$	200	
Pulsed drain current <sup>2)</sup>	/ <sub>D,pulse</sub>	T <sub>C</sub> = 25 °C	800	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	/ <sub>D</sub> = 100 A	280	mJ
Avalanche current, single pulse	I <sub>AS</sub>	-	200	А
Gate source voltage	V <sub>GS</sub>	-	±20	V
Power dissipation	P tot	T <sub>C</sub> =25 °C	167	W
Operating and storage temperature	$T_{\rm j}$ , $T_{\rm stg}$	-	-55 <b>+1</b> 75	°C

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# Thermal characteristics<sup>2)</sup>

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal resistance, junction - case	R thJC	-	-	-	0.90	K/W
Thermal resistance, junction - ambient	R thJA	6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	60	

### **Electrical characteristics**

at Tj=25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Static characteristics	•		•			-
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V},$ $I_D = 1 \text{ mA}$	40	-	-	V
Gate threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 100 \mu\text{A}$	2.2	2.8	3.4	]
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$ $T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$ $T_j = 125 \text{ °C}^{2)}$	-	-	100	
Gate-source leakage current	I <sub>GSS</sub>	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	$V_{\rm GS} = 7  \text{V}, I_{\rm D} = 100  \text{A}$	_	0.90	1.20	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 100 \text{ A}$	_	0.80	0.94	



99

4.7

132

Parameter	Symbol	Conditions	onditions Values			Unit
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	C iss		-	5750	7650	pF
Output capacitance	C oss	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V},$ f = 1  MHz	-	1600	2130	
Reverse transfer capacitance	C <sub>rss</sub>		-	80	120	
Turn-on delay time	t <sub>d(on)</sub>		-	11	-	ns
Rise time	t r	$V_{DD} = 20 \text{ V}, V_{GS} = 10 \text{ V},$ $I_{D} = 200 \text{ A}, R_{G} = 3.5 \Omega$	-	6	-	
Turn-off delay time	t <sub>d(off)</sub>		-	23	-	
Fall time	t f		-	12	-	
Gate Charge Characteristics <sup>2)</sup>						
Gate to source charge	Q gs		-	28	37	nC
Gate to drain charge	Q <sub>gd</sub>	$V_{DD} = 32 \text{ V}, I_{D} = 200 \text{ A},$	-	21	32	]

#### **Reverse Diode**

Gate charge total

Gate plateau voltage

Diode continous forward current <sup>2)</sup>	Is	T <sub>C</sub> = 25 °C	-	-	200	A
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	7 c - 25 C	ı	ı	800	
Diode forward voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V, } I_F = 100 \text{ A,}$ $T_j = 25 \text{ °C}$	-	0.8	1.1	V
Reverse recovery time <sup>2)</sup>	t rr	$V_R = 20 \text{ V}, I_F = 50 \text{ A},$ $di_F/dt = 100 \text{ A}/\mu\text{s}$	-	65	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>	$di_{F}/dt = 100 A/\mu s$	ı	80	ı	nC

 $V_{GS} = 0$  to 10 V

Q<sub>g</sub>

 $V_{\rm plateau}$ 

 $<sup>^{1)}</sup>$  Current is limited by package; with a Rthjc = 0.9 K/W the chip is able to carry 300 A at 25°C.

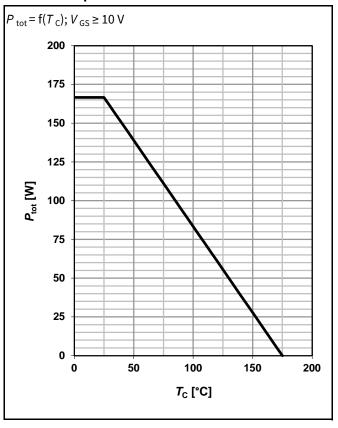
 $<sup>^{\</sup>rm 2)}$  The parameter is not subject to production test-verified by design/characterization.

<sup>&</sup>lt;sup>3)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

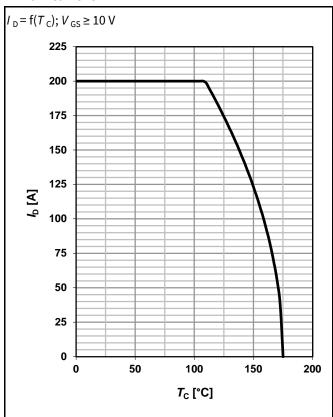


## **Electrical characteristics diagrams**

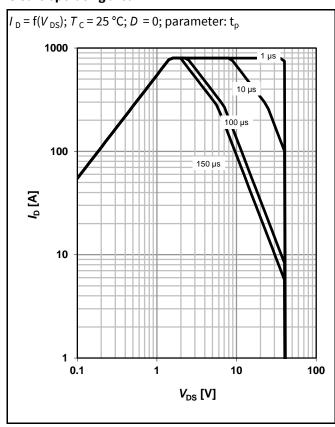
#### 1 Power dissipation



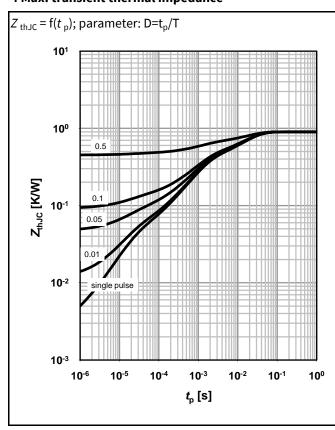
## 2 Drain current



#### 3 Safe operating area



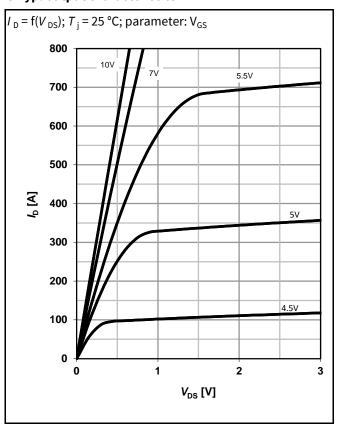
#### 4 Max. transient thermal impedance



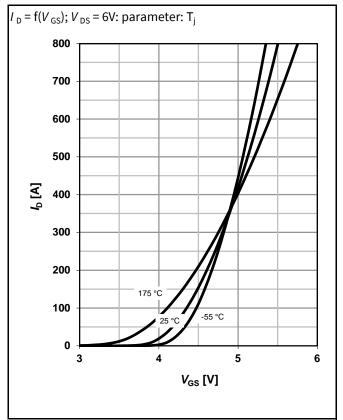
IAUA200N04S5N010



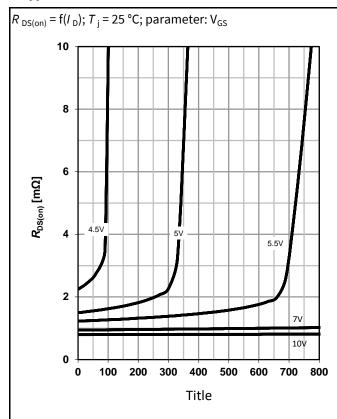
#### 5 Typ. output characteristics



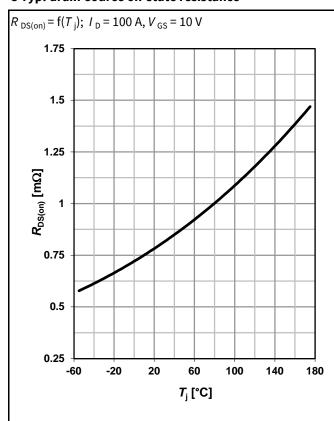
#### 7 Typ. transfer characteristics



#### 6 Typ. drain-source on-state resistance



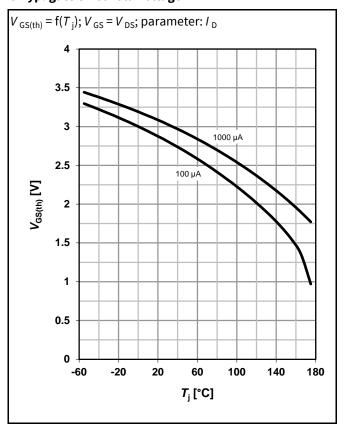
#### 8 Typ. drain-source on-state resistance

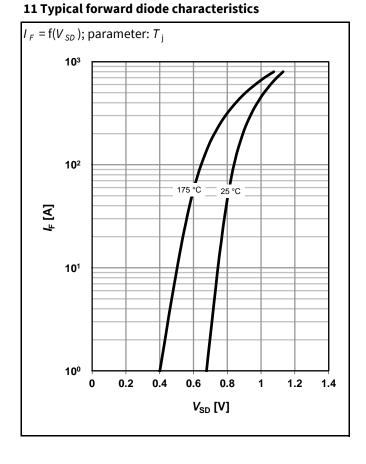


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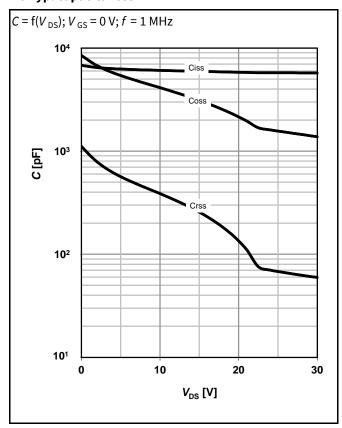


#### 9 Typ. gate threshold voltage

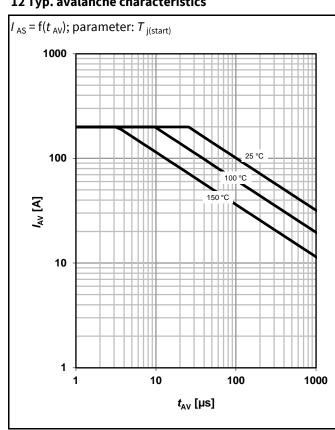




#### 10 Typ. capacitances

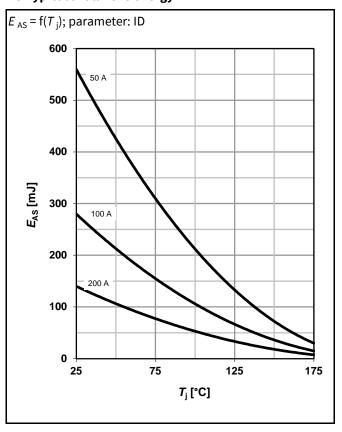


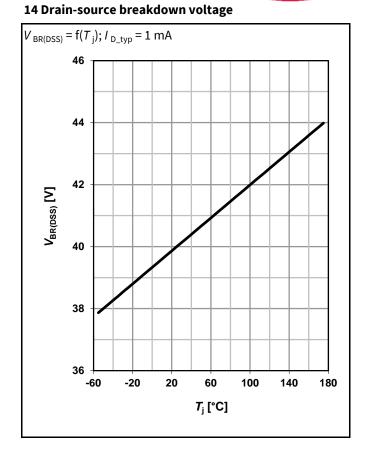
#### 12 Typ. avalanche characteristics



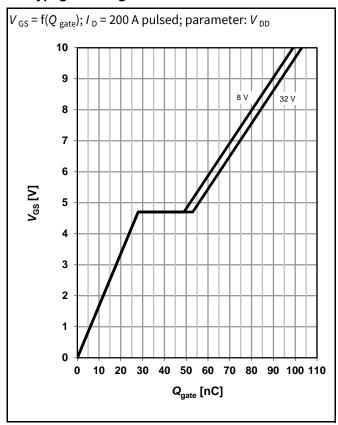
# infineon

#### 13 Typical avalanche energy

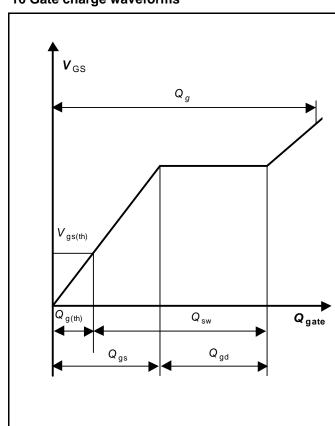




#### 15 Typ. gate charge



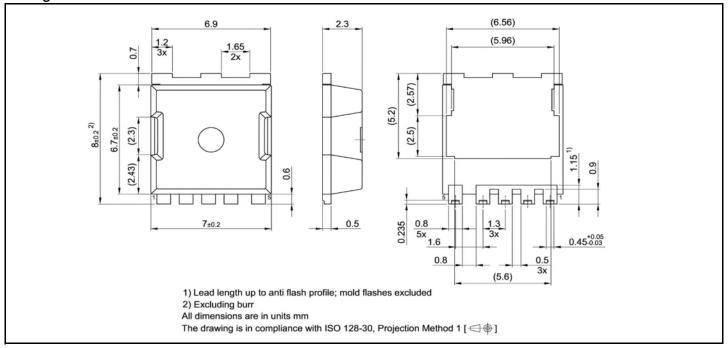
#### 16 Gate charge waveforms



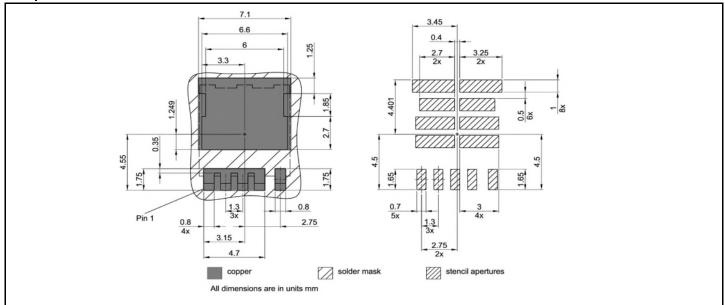
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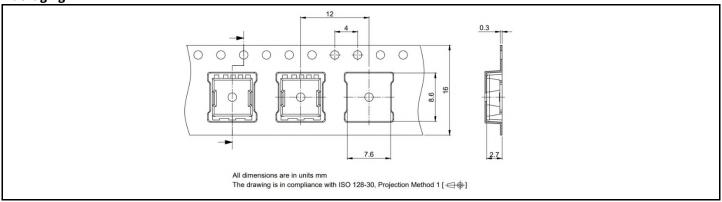
#### **Package Outline**



#### **Footprint**



#### **Packaging**



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# **Revision History**

Revision	Date	Changes
Revision 1.0	07.12.2017	Final Data Sheet
Revision 1.1	10.07.2018	Package name, SOA curve 10 μs
Revision 1.2	14.04.2021	RDS(on) improved
Revision 1.3	24.01.2022	Editorial changes, package drawing added
Revision 1.4	11.09.2023	Corrected avalanche current Graph

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